# **Segmented Photodiodes (SPOT Series)**

Position Sensing Detector (PSD)

The SPOT Series are common substrate photodetectors segmented into either two (2) or four (4) separate active areas. They are available with either a 0.005" or 0.0004" well defined gap between the adjacent elements resulting in high response uniformity between the elements. The SPOT series are ideal for very accurate nulling or centering applications. Position information can be obtained when the light spot diameter is larger than the spacing between the cells.

Spectral response range is from 350-1100nm. Notch or bandpass filters can be added to achieve specific spectral responses.

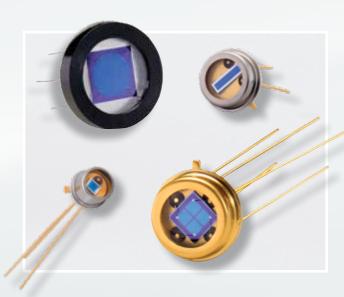
These detectors exhibit excellent stability over time and temperature, fast response times necessary for high speed or pulse operation, and position resolutions of better than 0.1  $\mu m$ . Maximum recommended power density is 10 mW / cm<sup>2</sup> and typical uniformity of response for a 1 mm diameter spot is ±2%.

#### **APPLICATIONS**

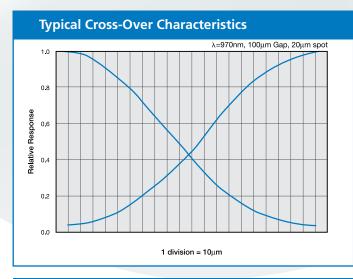
- Machine Tool Alignment
- Position Measuring
- Beam Centering
- Surface Profiling
- Targeting
- Guidance Systems

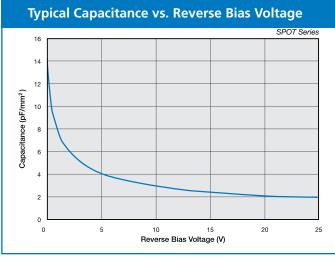
## **FEATURES**

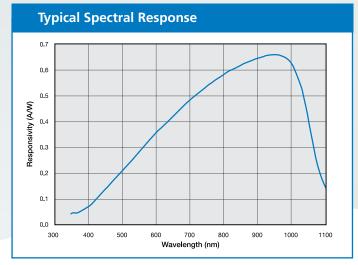
- High Accuracy
- Excellent Resolution
- High-Speed Response
- Ultra Low Dark Current
- Excellent Response Match
- High Stability over Time and Temperature

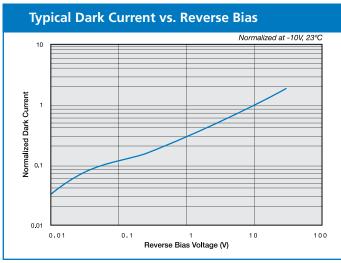


The circuit on the opposite page represents a typical biasing and detection circuit set up for both bi-cells and quad-cells. For position calculations and further details, refer to "Photodiode Characteristics" section of the catalog.



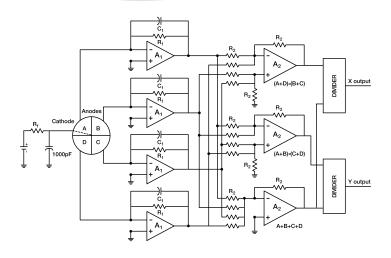






# Segmented Photodiodes (SPOT Series) Typical Electro-Optical Specifications at T<sub>A</sub>=23°C

Model Number	Active Area Per Element		(mm)	Responsivity (A/W)		Capacitance (pF)	Dark Current (nA)		NEP (W/√Hz)	Reverse	Rise Time (ns)	Ra	mp nge C)	
	(mm²)	Dimensions (mm)	Element Gap (n	970 nm		-10 V	-10 V		-10 V 970 nm	Voltage (V)	-10 V 780 nm 50 Ω		Storage	Package Style ¶
	Area (			min.	typ.	typ.	typ.	max.	typ.	max.	typ.	Operating	Stor	
Two-Elem	ent Se	ries, Me	tal Pack	cage										
CD-25T	2.3	4.6 x 0.5	0.020	-	0.65	50@ -15V	20@ -	15V		30	18	-40 ~ +100	-55 ~ +125	2 / TO-5
SPOT-2D	3.3	1.3 x 2.5	0.127			11	0.15	2.0	1.1 e-14		22			41 / TO-5
SPOT-2DMI	0.7	0.6 x 1.2	0.013	0.60	0.65	3	0.05	1.0	6.2 e-15		11			40 / TO-18
SPOT-3D	2.8	0.6 x 4.6	0.025			7	0.13	2.0	9.9 e-15		25			41 / TO-5
Four Elem	ent Se	eries, Me	tal Pacl	kage	,									
SPOT-4D	1.61	1.3 sq	0.127		0.65	5	0.10	1.0	8.7 e-15	30	22	-40 ~ +100	-55 ~ +125	41 / TO-5
SPOT-4DMI	0.25	0.5 sq	0.013	0.60		1	0.01	0.5	2.8 e-15		9			
SPOT-9D	19.6	10 φ ‡	0.102	0.60		60	0.50	10.0	1.9 e-14		33			43 / LoProf
SPOT-9DMI	19.6		0.010	1		60	0.50	10.0			28			



<sup>‡</sup> Overall Diameter (All four Quads) ¶ For mechanical drawings please refer to pages 61 thru 73. Chip centering within ±0.010".

# **Photodiode Care and Handling Instructions**

#### **AVOID DIRECT LIGHT**

Since the spectral response of silicon photodiode includes the visible light region, care must be taken to avoid photodiode exposure to high ambient light levels, particularly from tungsten sources or sunlight. During shipment from OSI Optoelectronics, your photodiodes are packaged in opaque, padded containers to avoid ambient light exposure and damage due to shock from dropping or jarring.

#### **AVOID SHARP PHYSICAL SHOCK**

Photodiodes can be rendered inoperable if dropped or sharply jarred. The wire bonds are delicate and can become separated from the photodiode's bonding pads when the detector is dropped or otherwise receives a sharp physical blow.

#### CLEAN WINDOWS WITH OPTICAL GRADE CLOTH / TISSUE

Most windows on OSI Optoelectronics photodiodes are either silicon or quartz. They should be cleaned with isopropyl alcohol and a soft (optical grade) pad.

#### **OBSERVE STORAGE TEMPERATURES AND HUMIDITY LEVELS**

Photodiode exposure to extreme high or low storage temperatures can affect the subsequent performance of a silicon photodiode. Storage temperature guidelines are presented in the photodiode performance specifications of this catalog. Please maintain a non-condensing environment for optimum performance and lifetime.

## **OBSERVE ELECTROSTATIC DISCHARGE (ESD) PRECAUTIONS**

OSI Optoelectronics photodiodes, especially with IC devices (e.g. Photops) are considered ESD sensitive. The photodiodes are shipped in ESD protective packaging. When unpacking and using these products, anti-ESD precautions should be observed.

#### DO NOT EXPOSE PHOTODIODES TO HARSH CHEMICALS

Photodiode packages and/or operation may be impaired if exposed to CHLOROTHENE, THINNER, ACETONE, or TRICHLOROETHYLENE.

#### **INSTALL WITH CARE**

Most photodiodes in this catalog are provided with wire or pin leads for installation in circuit boards or sockets. Observe the soldering temperatures and conditions specified below:

Soldering Iron: Soldering 30 W or less

Temperature at tip of iron 300°C or lower.

Dip Soldering: Bath Temperature: 260±5°C.

Immersion Time: within 5 Sec. Soldering Time: within 3 Sec.

Vapor Phase Soldering: DO NOT USE

Reflow Soldering: DO NOT USE

Photodiodes in plastic packages should be given special care. Clear plastic packages are more sensitive to environmental stress than those of black plastic. Storing devices in high humidity can present problems when soldering. Since the rapid heating during soldering stresses the wire bonds and can cause wire to bonding pad separation, it is recommended that devices in plastic packages to be baked for 24 hours at 85°C.

The leads on the photodiode **SHOULD NOT BE FORMED**. If your application requires lead spacing modification, please contact OSI Optoelectronics Applications group at (310)978-0516 before forming a product's leads. Product warranties could be voided.



\*Most of our standard catalog products are RoHS Compliant. Please contact us for details

## 1. Parameter Definitions:

- A = Distance from top of chip to top of glass.
- a = Photodiode Anode.
- B = Distance from top of glass to bottom of case.
- c = Photodiode Cathode
  - (Note: cathode is common to case in metal package products unless otherwise noted).
- W = Window Diameter.
- F.O.V. = Filed of View (see definition below).
- 2. Dimensions are in inches (1 inch = 25.4 mm).
- 3. Pin diameters are  $0.018 \pm 0.002$ " unless otherwise specified.
- 4. Tolerances (unless otherwise noted)

General: 0.XX ±0.01"

0.XXX ±0.005"

Chip Centering: ±0.010" Dimension 'A': ±0.015"

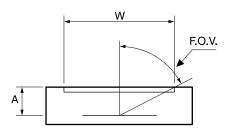
## 5. Windows

All 'UV' Enhanced products are provided with QUARTZ glass windows,  $0.027 \pm 0.002$ " thick.

All 'XUV' products are provided with removable windows.

All 'DLS' PSD products are provided with A/R coated glass windows.

All 'FIL' photoconductive and photovoltaic products are epoxy filled instead of glass windows.



$$F.O.V. = \tan^{-1}\left(\frac{W}{2A}\right)$$



For Further Assistance Please Call One of Our Experienced Sales and Applications Engineers

310-978-0516

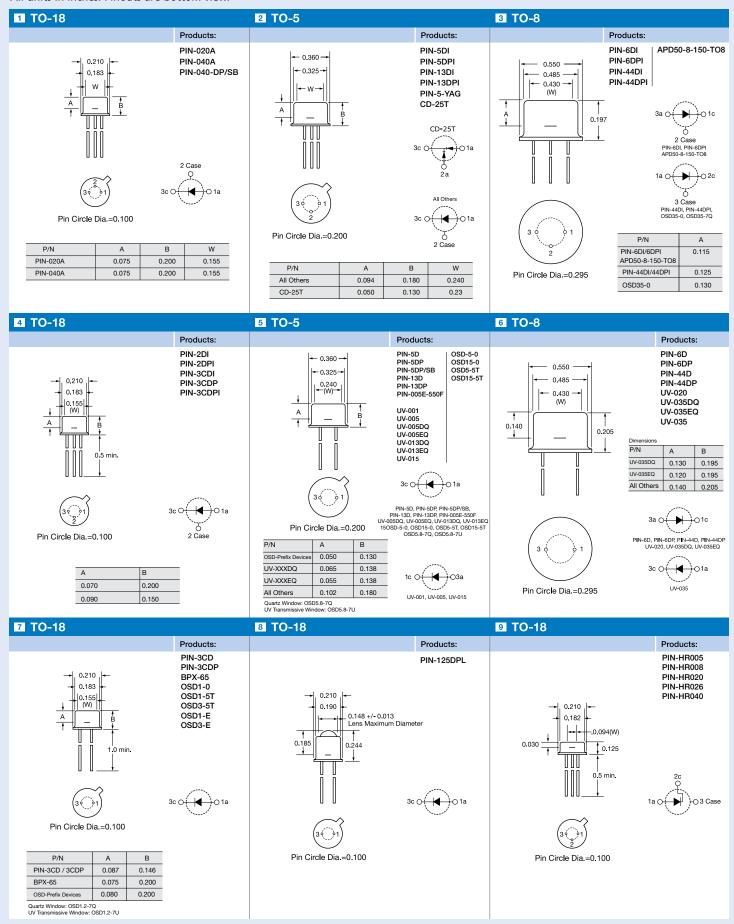
OSI Optoelectronics
An OSI Systems Company



- Or visit our website at
www.osioptoelectronics.com

## **Mechanical Specifications**

All units in inches. Pinouts are bottom view.



## **Mechanical Specifications**

